

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/664,768	LEVIN, CRAIG S.	
		Examiner	Art Unit	
		Faye Polyzos	2878	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,009,128 A	04-1991	Seidel et al.	477/122
	B	US-5,378,894 A	01-1995	Akai, Yoshimi	250/368
	C	US-6,245,184 B1	06-2001	Riedner et al.	156/247
	D	US-4,672,207	06-1987	Derenzzo, Stephen E.	250/363.02
	E	US-2002/0190214 A1	12-2002	Wieczorek et al.	250/367
	F	US-5,091,650 A	02-1992	Uchida et al.	250/366
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.